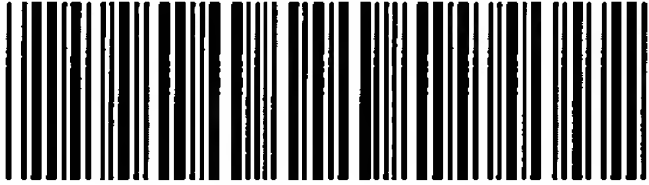


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/646,012	DEVLIN ET AL.	
	Examiner	Art Unit	
	David E. Martinez	2182	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
710/68-71 and 386/109, AND text search with keywords	10/25/2005	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, Derwen,t IBM_TDB.	10/25/2005	DM